



FQB6N60 / FQI6N60

600V N-Channel MOSFET

General Description

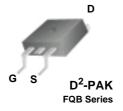
These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

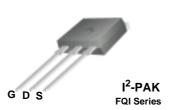
This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switch mode power supply.

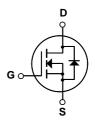
Features

- 6.2A, 600V, $R_{DS(on)} = 1.5\Omega$ @ $V_{GS} = 10$ V
- Low gate charge (typical 20 nC)
- Low Crss (typical 10 pF)
- · Fast switching
- 100% avalanche tested
- · Improved dv/dt capability
- · RoHS Compliant









Absolute Maximum Ratings $T_C = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter		FQB6N60 / FQI6N60	Units
V _{DSS}	Drain-Source Voltage		600	V
I _D	Drain Current - Continuous (T _C = 25°C) - Continuous (T _C = 100°C)		6.2	А
			3.9	А
I _{DM}	Drain Current - Pulsed	(Note 1)	24.8	Α
V _{GSS}	Gate-Source Voltage		± 30	V
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	440	mJ
I _{AR}	Avalanche Current	(Note 1)	6.2	А
E _{AR}	Repetitive Avalanche Energy	(Note 1)	13	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	4.5	V/ns
P_{D}	Power Dissipation (T _A = 25°C) *		3.13	W
	Power Dissipation (T _C = 25°C)		130	W
	- Derate above 25°C		1.04	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +150	°C
T _L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

Thermal Characteristics

Symbol	Parameter	Тур	Max	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		0.96	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient *		40	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		62.5	°C/W

* When mounted on the minimum pad size recommended (PCB Mount)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Cha	aracteristics					
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	600			V
ΔBV _{DSS} / ΔT _J	Breakdown Voltage Temperature Coefficient	$I_D = 250 \mu A$, Referenced to 25°C		0.53		V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 600 V, V _{GS} = 0 V			10	μΑ
		V _{DS} = 480 V, T _C = 125°C			100	μΑ
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 30 V, V _{DS} = 0 V			100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	V _{GS} = -30 V, V _{DS} = 0 V			-100	nA
On Cha	aracteristics					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	3.0		5.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10 V, I _D = 3.1 A		1.2	1.5	Ω
g _{FS}	Forward Transconductance	$V_{DS} = 50 \text{ V}, I_D = 3.1 \text{ A}$ (Note 4)		6.0		S
C _{oss} C _{rss}	Output Capacitance Reverse Transfer Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ $f = 1.0 \text{ MHz}$		95 10	120 13	pF pF
	,			10	10	Pi
	ing Characteristics	T		Т	1	
t _{d(on)}	Turn-On Delay Time	$V_{DD} = 300 \text{ V}, I_{D} = 6.2 \text{ A},$ $R_{G} = 25 \Omega$		20	50	ns
t _r	Turn-On Rise Time			70	150	ns
t _{d(off)}	Turn-Off Delay Time	(Note 4.5)		40	90	ns
t _f	Turn-Off Fall Time	(Note 4, 5)		45	100	ns
Qg	Total Gate Charge	$V_{DS} = 480 \text{ V}, I_{D} = 6.2 \text{ A},$		20	25	nC
Q _{gs}	Gate-Source Charge	V _{GS} = 10 V		4.9		nC
Q _{gd}	Gate-Drain Charge	(Note 4, 5)		9.4		nC
Drain-S	Source Diode Characteristics ar	nd Maximum Ratings				
I _S	Maximum Continuous Drain-Source Diode Forward Current				6.2	Α
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current				24.8	Α
V _{SD}	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_{S} = 6.2 \text{ A}$			1.4	V
			+		l	
t _{rr}	Reverse Recovery Time	$V_{GS} = 0 \text{ V}, I_{S} = 6.2 \text{ A},$		290		ns

- **Notes:**1. Repetitive Rating : Pulse width limited by maximum junction temperature 2. L = 21mH, I $_{AS}$ = 6.2A, V $_{DD}$ = 50V, R $_{G}$ = 25 Ω , Starting T $_{J}$ = 25°C 3. I $_{SD}$ ≤ 6.2A, di/dt ≤ 200A/µs, V $_{DD}$ ≤ BV $_{DSS}$, Starting T $_{J}$ = 25°C 4. Pulse Test : Pulse width ≤ 300 μ s, Duty cycle ≤ 2% 5. Essentially independent of operating temperature

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Typical Characteristics

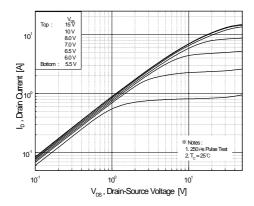


Figure 1. On-Region Characteristics

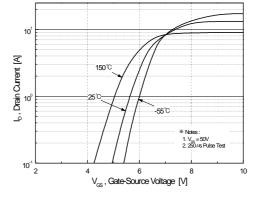


Figure 2. Transfer Characteristics

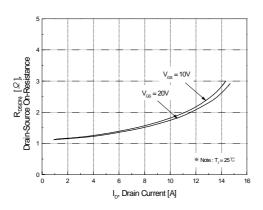


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

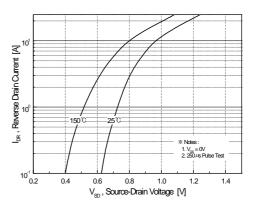


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

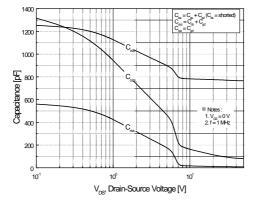


Figure 5. Capacitance Characteristics

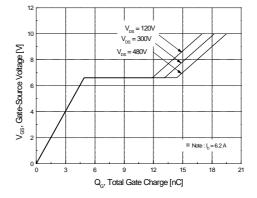


Figure 6. Gate Charge Characteristics

Typical Characteristics (Continued)

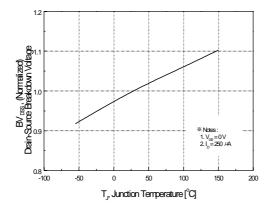
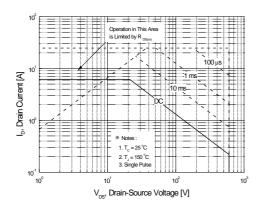


Figure 7. Breakdown Voltage Variation vs. Temperature

Figure 8. On-Resistance Variation vs. Temperature



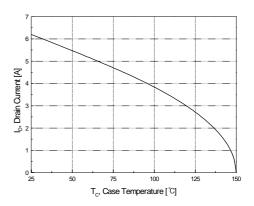


Figure 9. Maximum Safe Operating Area

Figure 10. Maximum Drain Current vs. Case Temperature

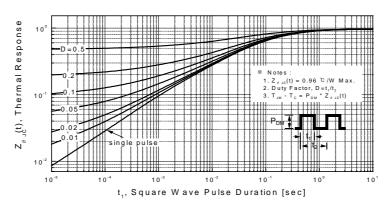
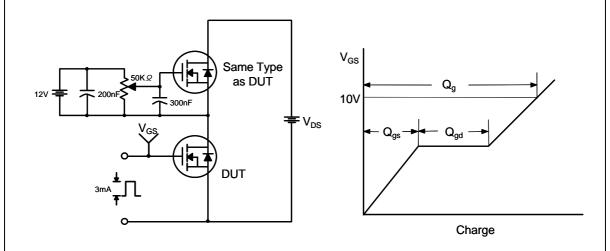


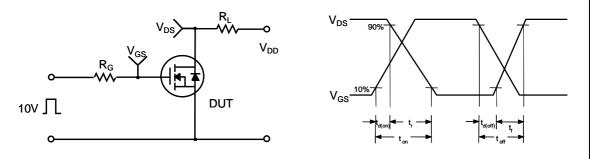
Figure 11. Transient Thermal Response Curve

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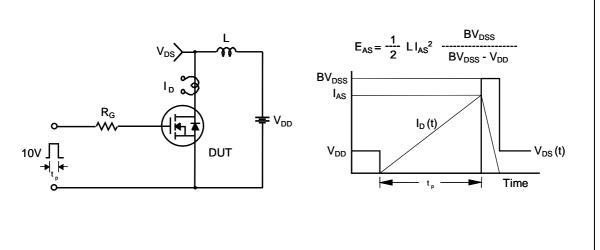
Gate Charge Test Circuit & Waveform



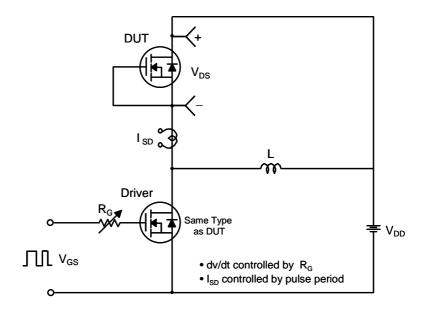
Resistive Switching Test Circuit & Waveforms

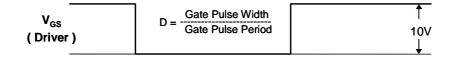


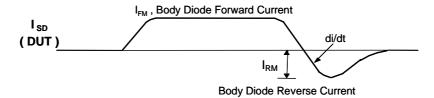
Unclamped Inductive Switching Test Circuit & Waveforms

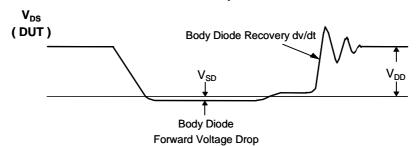


Peak Diode Recovery dv/dt Test Circuit & Waveforms







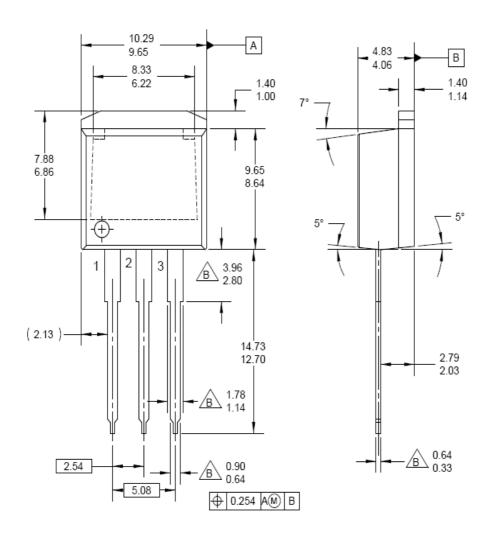


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Mechanical Dimensions D² - PAK -A-9.00 MIN 10.00 (2.12) -1.50 MIN ♦ 0.25 M B AM 5.08 LAND PATTERN RECOMMENDATION -B--6.22 MIN-1.65 1.14 6.86 MIN 15.88 14.61 · SEE DETAIL A 0.25 0.10 B .25 MAX SEATING PLANE Dimensions in Millimeters

Mechanical Dimensions

I² - PAK



Dimensions in Millimeters





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